

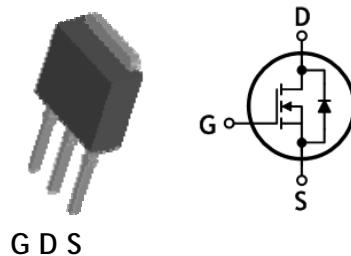
## SWITCHING REGULATOR APPLICATION

### Features

- $BV_{DSS}=800V$  Min.
- Low gate charge:  $Q_g=19nC$  (Typ.)
- Low drain-source On resistance:  $R_{DS(on)}=4.2\Omega$  (Max.)
- RoHS compliant device
- 100% avalanche tested

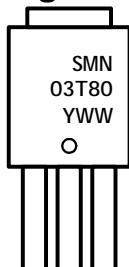
### Ordering Information

Part Number	Marking	Package
<b>SMN03T80IS</b>	<b>SMN03T80</b>	<b>I-PAK (Short Lead)</b>



I-PAK

### Marking Information



Column 1, 2: Device Code  
Column 3: Production Information  
e.g.) YWW  
-. YWW: Date Code (year, week)

### Absolute maximum ratings ( $T_c=25^\circ C$ unless otherwise noted)

Characteristic	Symbol		Rating	Unit
Drain-source voltage	$V_{DSS}$		800	V
Gate-source voltage	$V_{GSS}$		$\pm 30$	V
Drain current (DC) <sup>*</sup>	$I_D$	$T_c=25^\circ C$	3	A
		$T_c=100^\circ C$	1.83	A
Drain current (Pulsed) <sup>*</sup>	$I_{DM}$		12	A
Single pulsed avalanche energy <sup>(Note 2)</sup>	$E_{AS}$		200	mJ
Repetitive avalanche current <sup>(Note 1)</sup>	$I_{AR}$		3	A
Repetitive avalanche energy <sup>(Note 1)</sup>	$E_{AR}$		7	mJ
Power dissipation	$P_D$		70	W
Peak diode recovery dv/dt <sup>(Note 3)</sup>	$dv/dt$		4.5	V/ns
Junction temperature	$T_J$		150	°C
Storage temperature range	$T_{stg}$		-55~150	°C

\* Limited only maximum junction temperature

**Thermal Characteristics**

Characteristic	Symbol	Rating	Unit
Thermal resistance, junction to case	$R_{th(j-c)}$	Max. 1.78	$^{\circ}\text{C/W}$
Thermal resistance, junction to ambient	$R_{th(j-a)}$	Max. 110	

**Electrical Characteristics ( $T_c=25^{\circ}\text{C}$  unless otherwise noted)**

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$\text{BV}_{DSS}$	$I_D=250\mu\text{A}, V_{GS}=0$	800	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=250\mu\text{A}, V_{DS}=V_{GS}$	2	-	4	V
Drain-source cut-off current	$I_{DSS}$	$V_{DS}=800\text{V}, V_{GS}=0\text{V}$	-	-	10	$\mu\text{A}$
		$V_{DS}=640\text{V}, T_c=125^{\circ}\text{C}$	-	-	100	$\mu\text{A}$
Gate leakage current	$I_{GSS}$	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	$\pm 100$	nA
Drain-source on-resistance	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=1.5\text{A}$	-	3.36	4.2	$\Omega$
Forward transfer conductance <sup>(Note 4)</sup>	$g_{fs}$	$V_{DS}=30\text{V}, I_D=1.5\text{A}$	-	3.7	-	S
Input capacitance	$C_{iss}$	$V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1.0\text{MHz}$	-	696	-	pF
Output capacitance	$C_{oss}$		-	65	-	
Reverse transfer capacitance	$C_{rss}$		-	10.2	-	
Turn-on delay time <sup>(Note 4,5)</sup>	$t_{d(on)}$	$V_{DD}=400\text{V}, I_D=3\text{A}$ $R_G=25\Omega$	-	48	-	ns
Rise time <sup>(Note 4,5)</sup>	$t_r$		-	36	-	
Turn-off delay time <sup>(Note 4,5)</sup>	$t_{d(off)}$		-	106	-	
Fall time <sup>(Note 4,5)</sup>	$t_f$		-	41	-	
Total gate charge <sup>(Note 4,5)</sup>	$Q_g$	$V_{DS}=640\text{V}, V_{GS}=10\text{V}$ $I_D=3\text{A}$	-	19	-	nC
Gate-source charge <sup>(Note 4,5)</sup>	$Q_{gs}$		-	4	-	
Gate-drain charge <sup>(Note 4,5)</sup>	$Q_{gd}$		-	7.6	-	

**Source-Drain Diode Ratings and Characteristics ( $T_c=25^{\circ}\text{C}$  unless otherwise noted)**

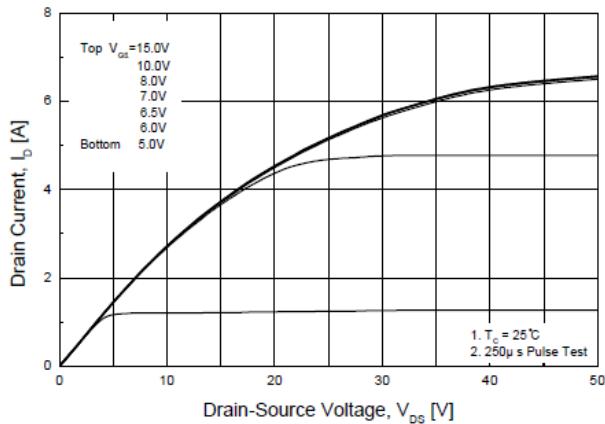
Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	$I_S$	Integral reverse diode in the MOSFET	-	-	3	A
Source current (Pulsed)	$I_{SM}$		-	-	12	A
Forward voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_S=3\text{A}$	-	-	1.5	V
Reverse recovery time <sup>(Note 4,5)</sup>	$t_{rr}$	$I_S=3\text{A}, V_{GS}=0\text{V}$ $dI_F/dt=100\text{A}/\mu\text{s}$	-	372	-	ns
Reverse recovery charge <sup>(Note 4,5)</sup>	$Q_{rr}$		-	1.8	-	uC

Note:

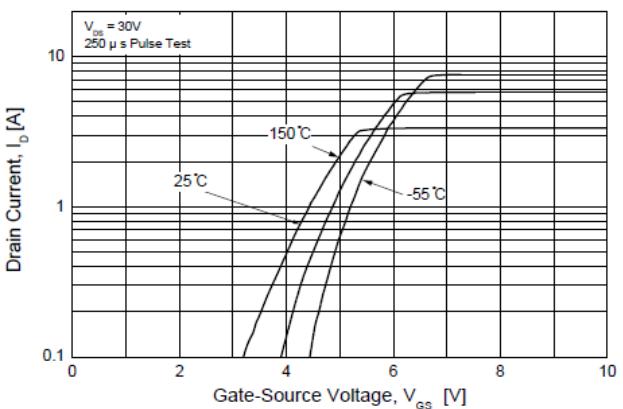
1. Repeated rating: Pulse width limited by safe operating area
2.  $L=42\text{mH}, I_{AS}=3\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$ , Starting  $T_J=25^{\circ}\text{C}$
3.  $I_{SD}\leq 3\text{A}, dI/dt\leq 200\text{A}/\mu\text{s}, V_{DD}\leq \text{BV}_{DSS}$ , Starting  $T_J=25^{\circ}\text{C}$
4. Pulse test: Pulse width  $\leq 300\text{us}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature typical characteristics

## Electrical Characteristic Curves

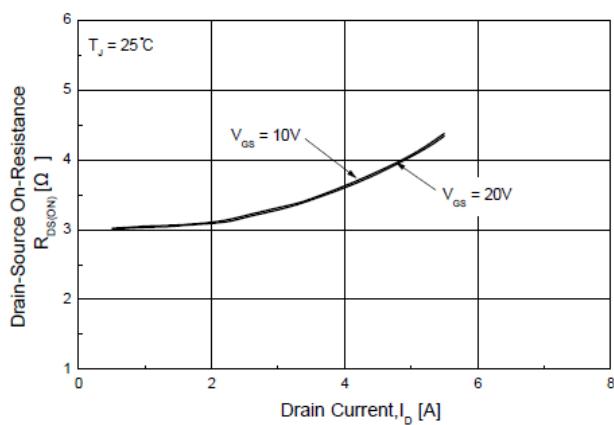
**Fig. 1**  $I_D$  -  $V_{DS}$



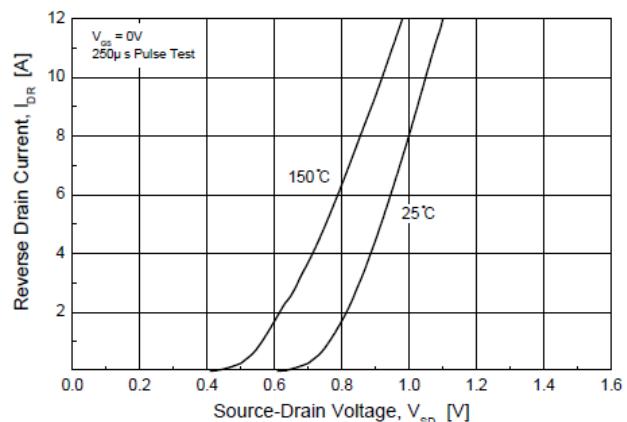
**Fig. 2**  $I_D$  -  $V_{GS}$



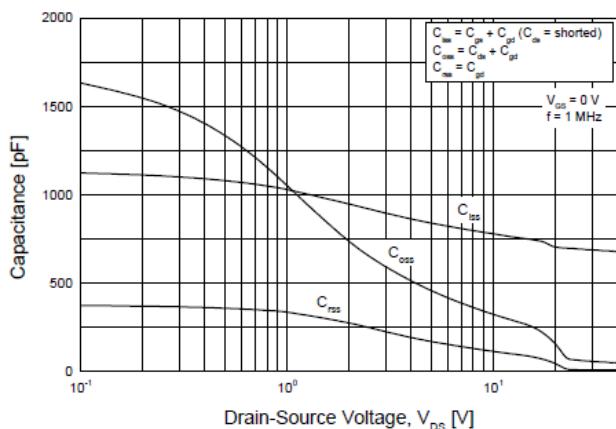
**Fig. 3**  $R_{DS(ON)}$  -  $I_D$



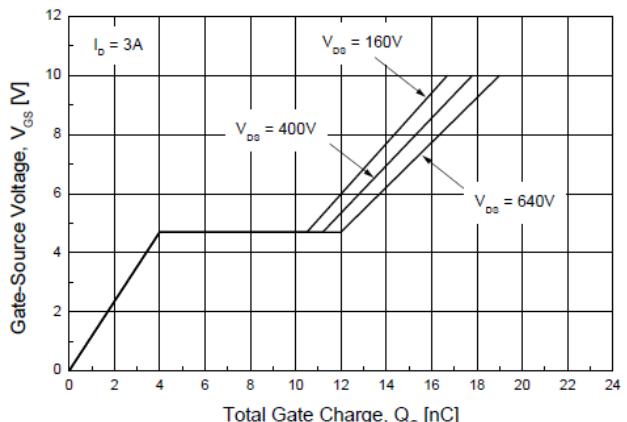
**Fig. 4**  $I_{DR}$  -  $V_{SD}$



**Fig. 5** Capacitance -  $V_{DS}$

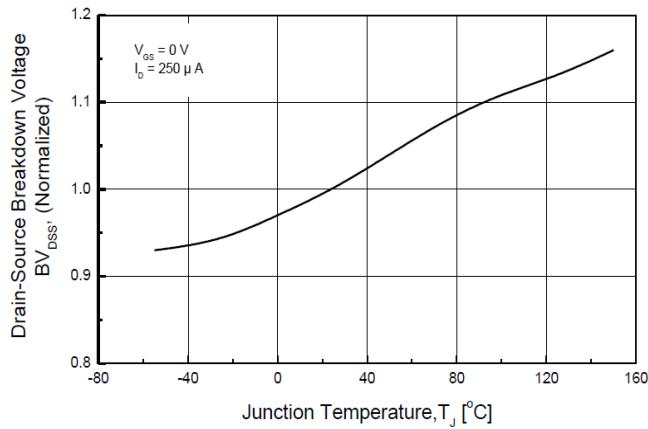


**Fig. 6**  $V_{GS}$  -  $Q_G$

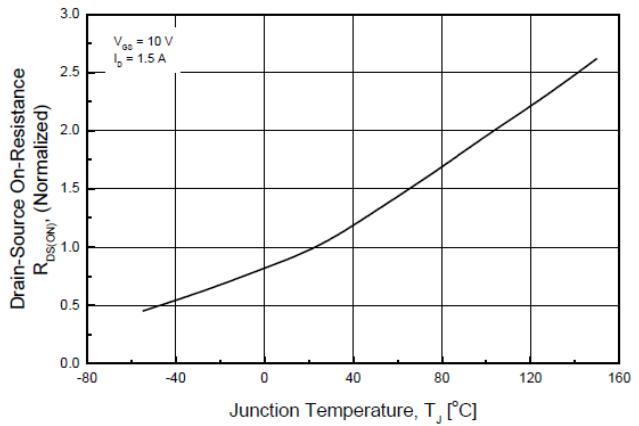


## Electrical Characteristic Curves (Continue)

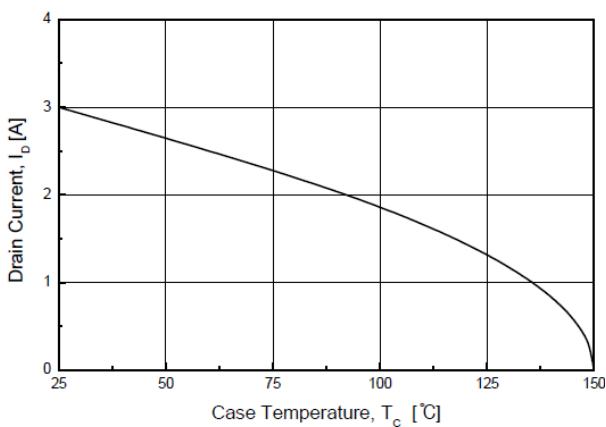
**Fig. 7  $BV_{DSS}$  -  $T_J$**



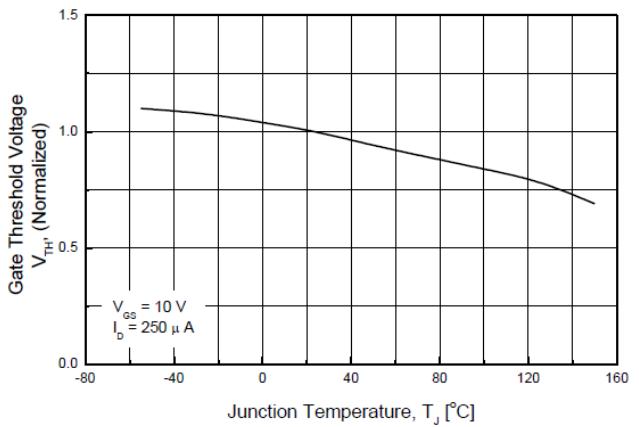
**Fig. 8  $R_{DS(ON)}$  -  $T_J$**



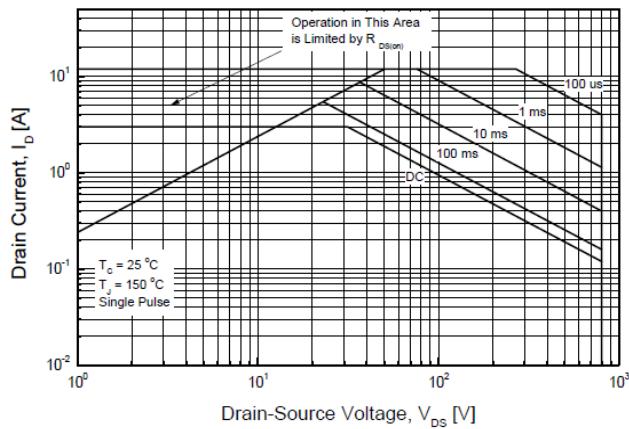
**Fig. 9  $I_D$  -  $T_c$**



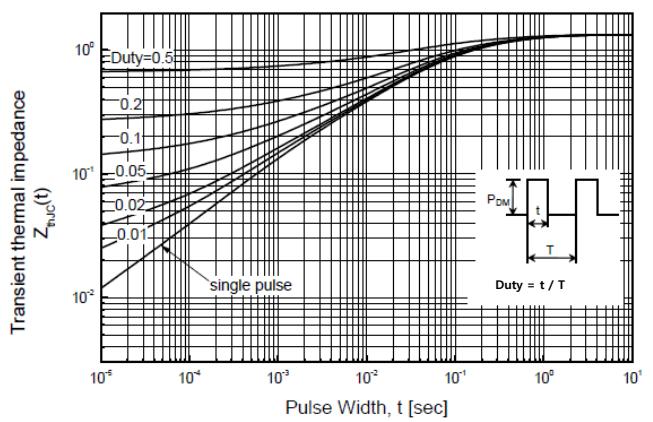
**Fig. 10  $V_{GS(th)}$  -  $T_J$**



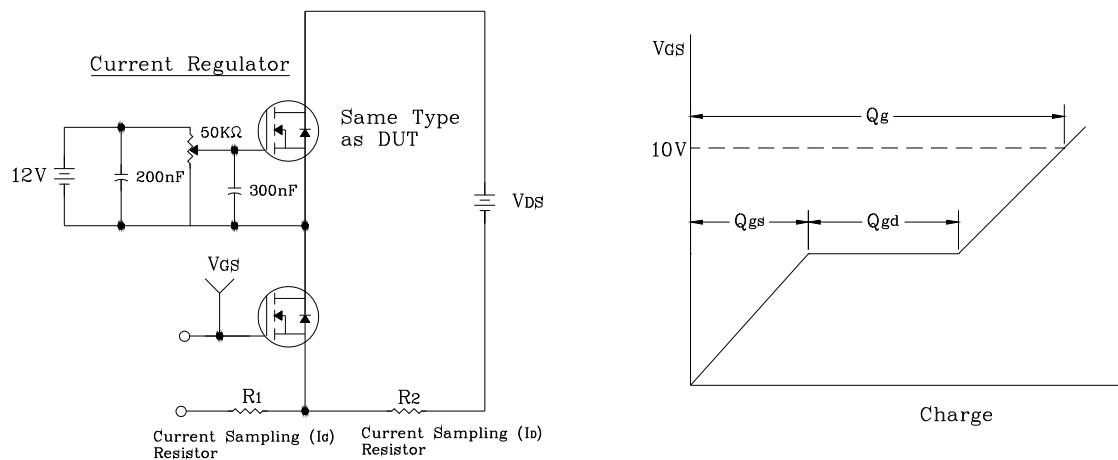
**Fig. 11 Safe Operating Area**



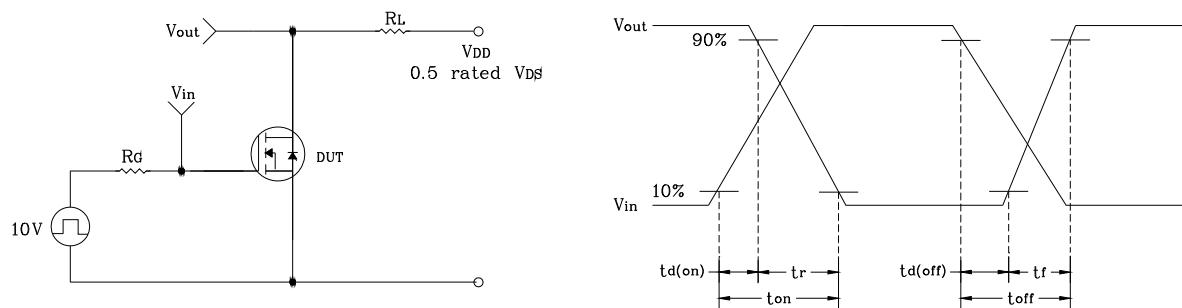
**Fig. 12  $Z_{th(j-c)}$  -  $t$**



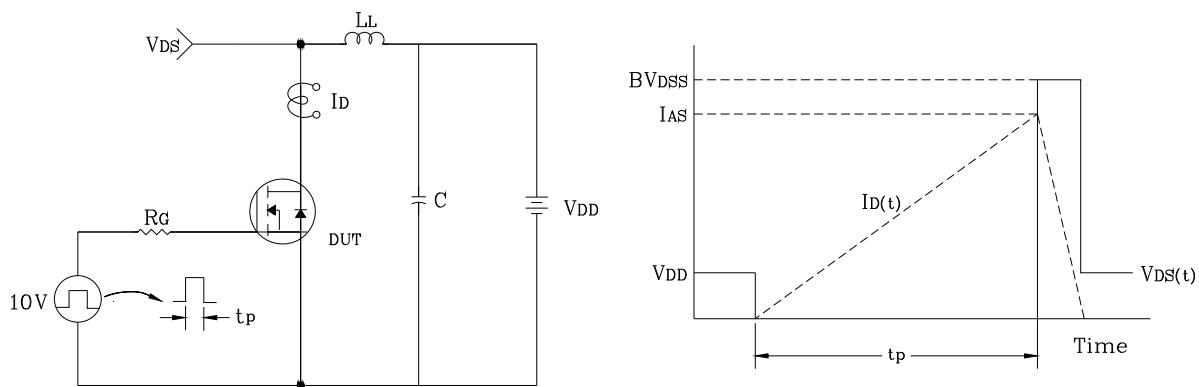
**Fig. 13 Gate Charge Test Circuit & Waveform**



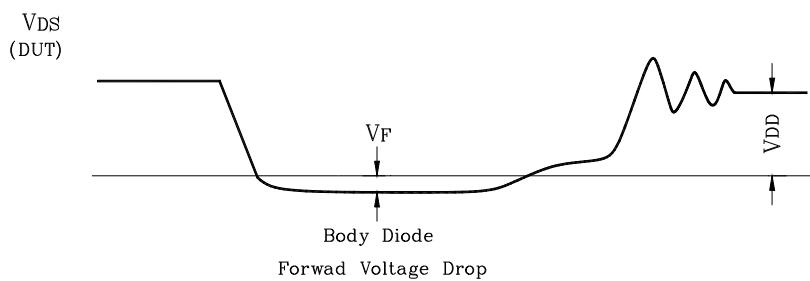
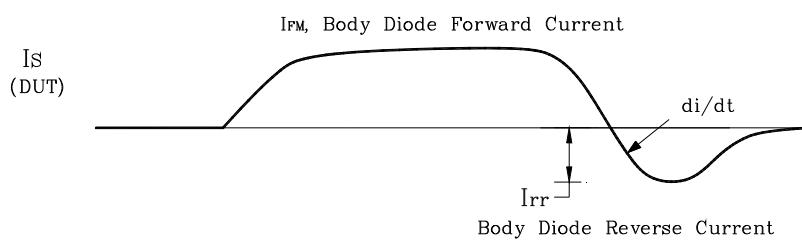
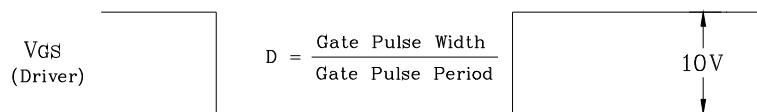
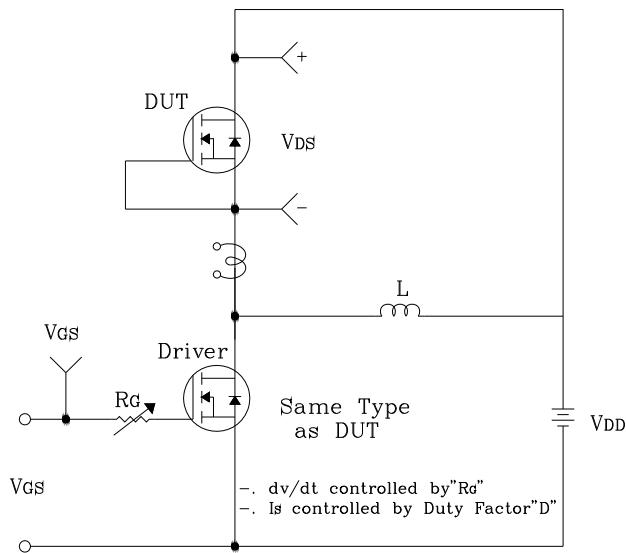
**Fig. 14 Resistive Switching Test Circuit & Waveform**

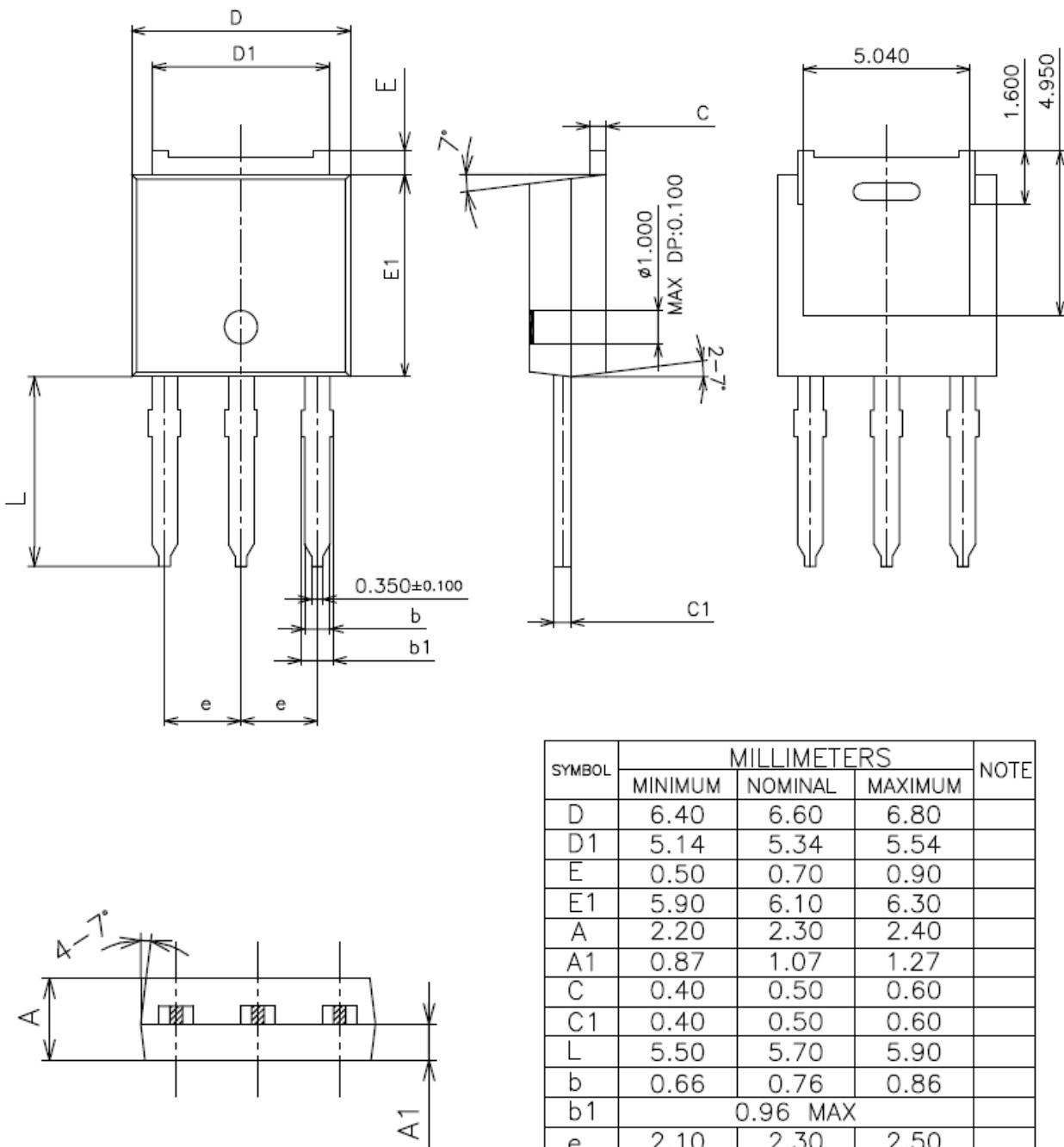


**Fig. 15  $E_{AS}$  Test Circuit & Waveform**



**Fig. 16 Diode Reverse Recovery Time Test Circuit & Waveform**



**Package Outline Dimensions**

**The AUK Corp. products are intended for the use as components in general electronic equipment (Office and communication equipment, measuring equipment, home appliance, etc.).**

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